

Description

The AP60N03NF uses advanced trench technology to provide excellent $R_{DS(ON)}$, low gate charge and operation with gate voltages as low as 4.5V. This device is suitable for use as a Battery protection or in other Switching application.

G S S

General Features

 $V_{DS} = 30V I_{D} = 60A$

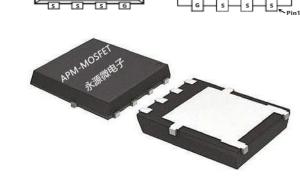
 $R_{DS(ON)} < 8.5 m\Omega V_{GS} = 10V$



Battery protection

Load switch

Uninterruptible power supply



Package Marking and Ordering Information

Product ID	Pack	Marking	Qty(PCS)
AP60N03NF	PDFN5*6-8L	AP60N03NF XXX YYYY	5000

Absolute Maximum Ratings (T_C=25 ℃unless otherwise noted)

Symbol Parameter		Rating	Units	
V _{DS}	Drain-Source Voltage	30	V	
Vgs	Gate-Source Voltage	±20	V	
I _D @T _C =25°C	Continuous Drain Current, V _{GS} @ 10V ¹	60	А	
I _D @T _C =100°C	Continuous Drain Current, V _{GS} @ 10V ¹	Continuous Drain Current, V _{GS} @ 10V ¹ 38		
I _D @T _A =25°C	Continuous Drain Current, V _{GS} @ 10V ¹ 12		А	
I _D @T _A =70°C	Continuous Drain Current, V _{GS} @ 10V ¹ 9.6		А	
Ідм	Pulsed Drain Current ² 115		А	
EAS	Single Pulse Avalanche Energy ³	57.8	mJ	
las	Avalanche Current	Avalanche Current 34		
P _D @T _C =25°C	Total Power Dissipation ⁴	Total Power Dissipation ⁴ 46		
P _D @T _A =25°C	Total Power Dissipation ⁴ 2		W	
Тѕтс	Storage Temperature Range -55 to 150		°C	
TJ	Operating Junction Temperature Range	-55 to 150	°C	
Reja	Thermal Resistance Junction-Ambient ¹	62	°C/W	
Rejc	Thermal Resistance Junction-Case ¹	-Case ¹ 2.7		



Electrical Characteristics (T_J=25 °C, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit	
BVDSS	Drain-Source Breakdown Voltage	V _{GS} =0V , I _D =250uA	30			V	
∆BVdss/∆TJ	BVDSS Temperature Coefficient	Reference to 25°C , I _D =1mA		0.027		V/°C	
	_	V _{GS} =10V , I _D =30A		6.5	8.5		
RDS(ON)	Static Drain-Source On-Resistance ²	V _{GS} =4.5V , I _D =15A		11	14	mΩ	
VGS(th)	Gate Threshold Voltage	V _{GS} =V _{DS} , I _D =250uA	1.2	1.5	2.5	V	
$\triangle V_{GS(th)}$	V _{GS(th)} Temperature Coefficient	·		-5.8		mV/°C	
loss	Drain-Source Leakage Current	V_{DS} =24V , V_{GS} =0V , T_J =25 $^{\circ}$ C			1		
IDSS	Diam-Source Leakage Current	V_{DS} =24V , V_{GS} =0V , T_J =55 $^{\circ}$ C			5	uA	
Igss	Gate-Source Leakage Current	V_{GS} = $\pm 20V$, V_{DS} = $0V$			±100	nA	
gfs	Forward Transconductance	V_{DS} =5 V , I_{D} =30 A		38		S	
R_g	Gate Resistance	V _{DS} =0V , V _{GS} =0V , f=1MHz		1.7	2.9	Ω	
Qg	Total Gate Charge (4.5V)			12.6	17.6		
Qgs	Gate-Source Charge	V _{DS} =15V , V _{GS} =4.5V , I _D =15A		4.2	5.9	nC	
Q _{gd}	Gate-Drain Charge			5.1	7.1		
T _{d(on)}	Turn-On Delay Time			4.6	9.2		
Tr	Rise Time	V _{DD} =15V , V _{GS} =10V ,		12.2	22	ns	
Td(off)	Turn-Off Delay Time	—R _G =3.3 —I _D =15A		26.6	53		
T _f	Fall Time	ID-15A		8	16		
Ciss	Input Capacitance			1317	1844		
Coss	Output Capacitance	V _{DS} =15V , V _{GS} =0V , f=1MHz		163	228	pF	
Crss	Reverse Transfer Capacitance			131	183		
Is	Continuous Source Current ^{1,5}				58	Α	
Іѕм	Pulsed Source Current ^{2,5}	V _G =V _D =0V , Force Current			115	Α	
VsD	Diode Forward Voltage ²	V _{GS} =0V , I _S =1A , T _J =25°C			1	V	
t _{rr}	Reverse Recovery Time	I=-20A		9.2		nS	
Qrr	Reverse Recovery Charge	IF=30A , dl/dt=100A/μs , T _J =25°C		2		nC	

Note:

- 1. The data tested by surface mounted on a 1 inch2 FR-4 board with 2OZ copper.
- 2.The data tested by pulsed , pulse width \leq 300us , duty cycle \leq 2%
- 3.The EAS data shows Max. rating . The test condition is VDD=25V,VGS=10V,L=0.1mH,IAS=34A
- 4.The power dissipation is limited by 150°C junction temperature
- 5.The data is theoretically the same as ID and IDM , in real applications , should be limited by total power dissipation.



Typical Characteristics

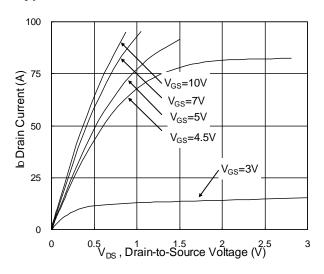


Fig.1 Typical Output Characteristics

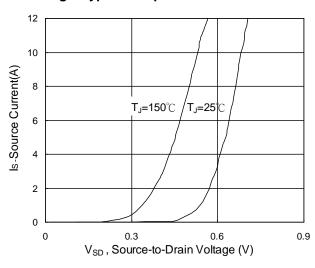


Fig.3 Forward Characteristics of reverse

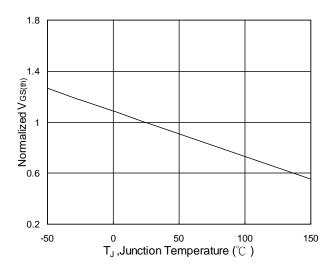


Fig.5 Normalized $V_{GS(th)}$ vs. T_J AP60N03NF Rve1.0

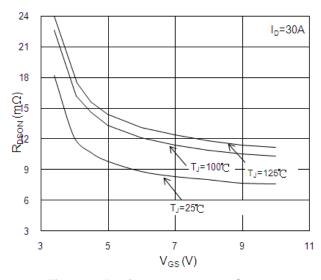


Fig.2 On-Resistance vs. Gate-Source

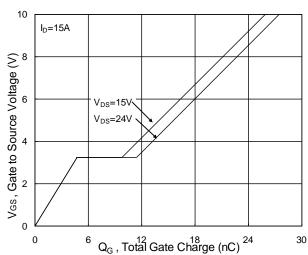


Fig.4 Gate-Charge Characteristics

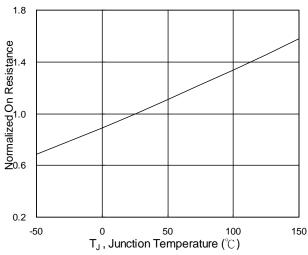
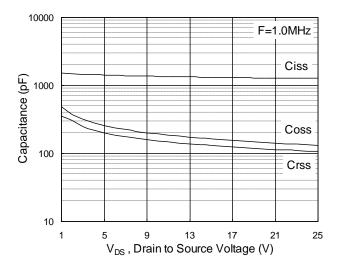


Fig.6 Normalized R_{DSON} vs. T」 臺灣永源微電子科技有限公司







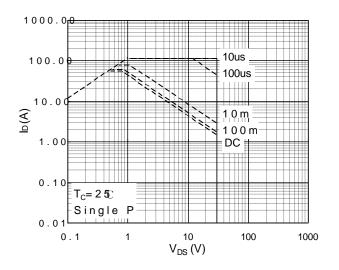


Fig.7 Capacitance

Fig.8 Safe Operating Area

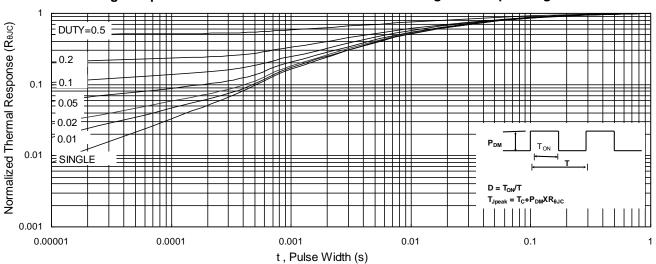
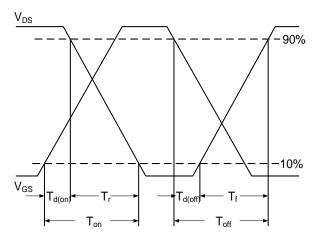


Fig.9 Normalized Maximum Transient Thermal Impedance





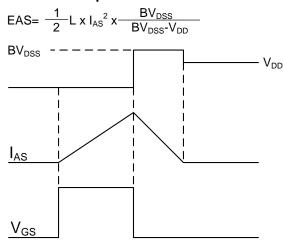
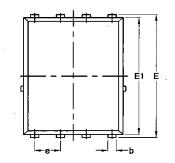


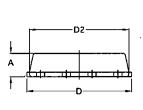
Fig.17 Unclamped Inductive Switching Waveform

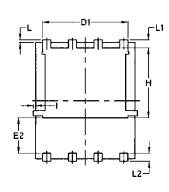


Package Mechanical Data-DFN5*6-8L-JQ Single









	Common				
Symbol	mm		Inch		
	Mim	Max	Min	Max	
Α	1.03	1.17	0.0406	0.0461	
b	0.34	0.48	0.0134	0.0189	
С	0.824	0.0970	0.0324	0.082	
D	4.80	5.40	0.1890	0.2126	
D1	4.11	4.31	0.1618	0.1697	
D2	4.80	5.00	0.1890	0.1969	
Е	5.95	6.15	0.2343	0.2421	
E1	5.65	5.85	0.2224	0.2303	
E2	1.60	/	0.0630	/	
е	1.27 BSC		0.05 BSC		
L	0.05	0.25	0.0020	0.0098	
L1	0.38	0.50	0.0150	0.0197	
L2	0.38	0.50	0.0150	0.0197	
Н	3.30	3.50	0.1299	0.1378	
I	/	0.18	/	0.0070	



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